

# SWITCH-MODE SOLENOID DRIVER

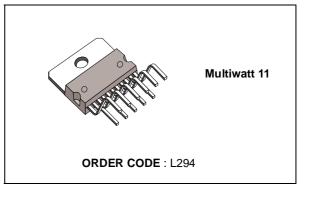
- HIGH VOLTAGE OPERATION (UP TO 50V)
- HIGHOUTPUT CURRENT CAPABILITY (UP TO 4A)

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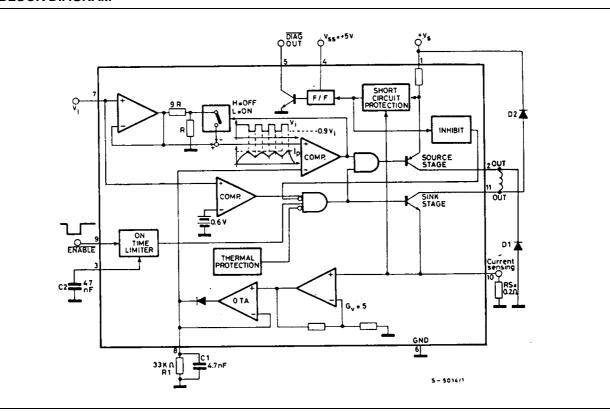
- LOW SATURATION VOLTAGE
- TTL-COMPATIBLE INPUT
- OUTPUT SHORT CIRCUIT PROTECTION (TO GROUND, TO SUPPLY AND ACROSS THE LOAD)
- THERMAL SHUTDOWN
- OVERDRIVING PROTECTION
- LATCHED DIAGNOSTIC OUTPUT

### DESCRIPTION

The L294 is a monolithic switched mode solenoid driver designed for fast, high current applications such as hummer and needle driving in printers and electronic typewriters. Power dissipation is reduced by efficient switchmode operation. An extra



feature of the L294 is a latched diagnostic output which indicates when the output is short circuited. The L294 is supplied in a 11-lead Multiwatt® plastic power package.

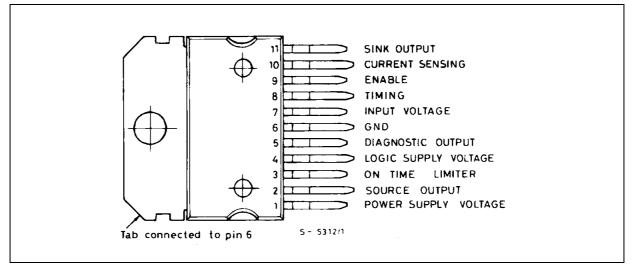


# BLOCK DIAGRAM

# **ABSOLUTE MAXIMUM RATING**

Symbol	Parameter	Value	Unit
Vs	Power Supply Voltage	50	V
V <sub>SS</sub>	Logic Supply Voltage	7	V
V <sub>EN</sub>	Enable Voltage	7	V
I <sub>p</sub>	Peak Output Current (repetitive)	4.5	А
P <sub>tot</sub>	Total Power Dissipation (at T <sub>case</sub> = 75 °C)	25	W
T <sub>stg</sub> , T <sub>j</sub>	Storage and Junction Temperature	- 40 to 150	°C

# **CONNECTION DIAGRAM** (top view)



### THERMAL DATA

Symbol	Parameter	Value	Unit
Rth-j-case	Thermal resistance junction-case Max	3	°C/W



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Vs	Power Supply Voltage (pin 1)	Operative Condition	12		46	V
l <sub>d</sub>	Quiescent Drain Current (pin 1)	V <sub>ENABLE</sub> = H		20	30	mA
		$Vi \ge 0.6V; V_{ENABLE} = L$		70		IIIA
V <sub>ss</sub>	Logic Suply Voltage (pin 4)		4.5		7	V
I <sub>ss</sub>	Quiescent Logic Supply	$V_{DIAG} = L$		5	8	mA
	Current	DIAG Output at High Impedance		10	100	μΑ
Vi	Input Voltage (pin 7)	Operating Output	0.6			V
		Non-operative Output			0.45	
li	Input Current (pin 7)	$V_i \ge 0.6V$		-1		μA
		$V_i \leq 0.45 V$		-3		μΑ
VENABLE	Enable Input Voltage (pin 9)	Low Level	-0.3		0.8	v
		High Level	2.4			v
IENABLE	Enable Input Current (pin 9)	V <sub>ENABLE</sub> = L			-100	μA
		V <sub>ENABLE</sub> = H			100	
$I_{load}/V_i$	Trasconductance	$R_S = 0.2 \Omega$ $V_i = 1V$	0.95	1	1.05	A/V
		$V_i = 4V$	0.97	1	1.3	Ä
Vsat H	Source Output Saturation Voltage	lp = 4A		1.7		V
V <sub>sat L</sub>	Sink Output Saturation Voltage	Ip = 4A		2		V
/ <sub>sat H +</sub> V <sub>satL</sub>	Total Saturation Voltage	$I_p = 4A$			4.5	V
I <sub>leakage</sub>	Output Leakage Current	$Rs = 0.2\Omega; \ Vi \le 0.45 \ V$		1		mA
К	On Time Limiter Constant (°)	V <sub>ENABLE</sub> = L		120		
V <sub>DIAG</sub>	Diagnostic Output Voltage (pin 5)	I <sub>DIAG</sub> = 10 mA			0.4	V
I <sub>DIAG</sub>	Diagnostic Leakage Current (pin 5)	V <sub>DIAG</sub> = 40V			10	μA
V <sub>pin</sub> 8 V <sub>pin</sub> 10	OP AMP and OTA CD Voltage Gain (°°)	$V_{pin \ 10} = 100 \text{ to } 800 \text{ mV}$		5		
V <sub>SENS</sub>	Sensing Voltage (pin 10) (°°°)				0.9	V

**ELECTRICAL CHARACTERISTICS** (refer to the test circuit,  $V_s = 40$  V,  $V_{ss} = 5$ V,  $T_{amb} = 25$  °C, unless otherwise specified)

 $\label{eq:constraint} \begin{array}{l} (^{\circ}) & \mbox{After a time interval } t_{max} = KC_2, \mbox{ the output stages are disabled.} \\ (^{\circ\circ}) & \mbox{See the block diagram.} \\ (^{\circ\circ\circ}) & \mbox{Allowed range of } V_{\text{SENS}} \mbox{ without intervention of the short circuit protection.} \end{array}$ 



#### **CIRCUIT OPERATION**

The L294 work as a trasconductance amplifier: it can supply an output current directly proportional to an input voltage level ( $V_i$ ). Fyrthermore, it allows complete switching control of the output current waveform (see fig. 1).

The following explanation refers to the Block Diagram, to fig. 1 and to the typical application circuit of fig. 2.

The  $t_{on}$  time is fixed by the width of the Enable input signal (TTL compatible): it is active low and enables the output stages "source" and "sink". At the end of  $t_{on}$ , the load current  $I_{load}$  recirculates through D1 and D2, allowing fast current turn-off.

The rise time  $t_r$ , depends on the load characteristics, on V<sub>i</sub> and on the supply voltage value (V<sub>s</sub>, pin 1). During the t<sub>on</sub> time, I<sub>load</sub> is converter into a voltage signal by means of the external sensing resistance R<sub>s</sub> connected to pin 10. This signal, amplified by the op amp and converted by the transconductance amplifier OTA, charges the external RC network at pin 8 (R1, C1). The voltage at this pin is sensed by the inverting input of a comparator. The voltage on the non-inverting input of this one is fixed by the external voltage V<sub>i</sub> (pin 7).

After  $t_r$ , the comparator switches and the output stage "source" is switched off. The comaprator output is confirmed by the voltage on the non-inverting input, which decreases of a costant fraction of V<sub>i</sub> (1/10), allowing hysteresis operation. The current in the load now flow through D1.

Two Cases are possible: the time constant of the recirculation phase is higher than R1.C1; the time constant is lower than R1.C1. In the first case, the voltage sensed in the non-inverting input of the comparator is just the value proportional to  $I_{load}$ . In the second case, when the current decreases too quickly, the comparator senses the voltage signal stored in the R1 C1 network.

In the first case  $t_1$  depends on the load characteristics, while in the second case it depends only on the value of R1. C1.

In the other words, R1. C1 fixes the minimum value of  $t_1$  ) $t_1 \ge 1/10$  R1.C1. Note that C1 should be chosen in the range 2.7 to 10 nF for stability reasons of the OTA).

After  $t_1$ , the comparator switches again: the output is confirmed by the voltage on the non-inverting input, which reaches  $V_i$  again (hysteresis).

Now the cycle starts again:  $t_2$ ,  $t_4$  and  $t_6$  have the same characteristics as  $t_r$ , while  $t_3$  and  $t_5$  are similar

to  $t_1$ . The peak current  $I_p$  depends on  $V_i$  as shown in the typical transfer function of fig.3.

It can be seen that for  $V_i$  lower than 450 mV the device is not operating.

For V<sub>i</sub> greater than 600 mV, the L294 has a transconductance of 1A/V with  $R_s = 0.2\Omega$ . For V<sub>i</sub> included between 450 and 600 mV, the operation is not guaranteed.

The order parts of the device have protection and diagnostic functions. At pin 3 is connected an external capacitor C2, charged at costant current when the Enable is low.

After a time interval equal to K C2 (K is defined in the table of Electrical Characteristics and has the dimensions of ohms) the output stages are switched off independently by the Input signal.

This avoids the load being driven in conduction for an excessive period of time (overdriving protection). The action of this protection is shown in fig. 1b. Note that the voltage ramp at pin 3 starts whenever the Enable signal becomes active (low state), regardless of the Input signal. To reset pin 3 and to restore the normal conditions, pin 9 must return high.

This protection can be disabled by grounding pin 3. The thermal protection included in the L294 has a hysteresis.

It switches off the output stages whenever the junction temperature increases too much. After a fall of about 20°C, the circuit starts again.

Finally, the device is protected against any type of short circuit at the outputs: to ground, to supply and across the load.

When the source stage current is higher than 5A and/or when the pin 10 voltage is higher then 1V (i.e. for a sink current greater than  $1V/R_s$ ) the output stages are switched off and the device is inhibited.

This condition is indicated at the open-collector output DIAG (pin 5); the internal flip-flop F/F changes and forces the output transistor into saturation. The F/F must be supplied independently through  $V_{ss}$  (pin 4). The DIAG signal is reset and the output stages are still operative by switching the device on again. After that, two cases are possible: the reason for the "bad operation" is still present and the protection acts again; the reason has been removed and the device starts to work properly.





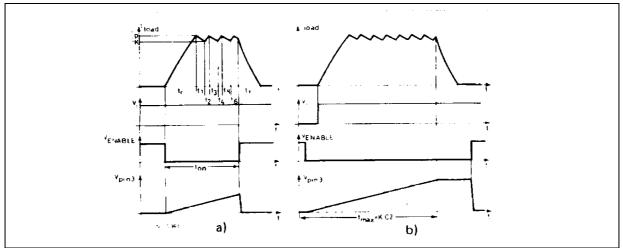


Figure 2. Test and Typical Application Circuit.

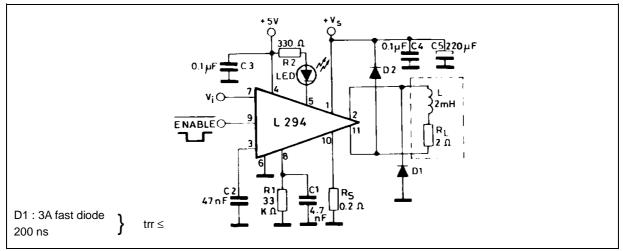


Figure 3. Peak Output Current vs. Input Voltage.

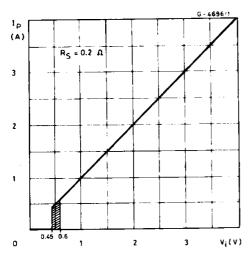


Figure 4. Output Saturation Voltage vs. Peak Output Current.

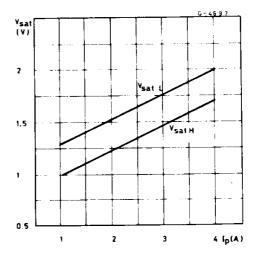
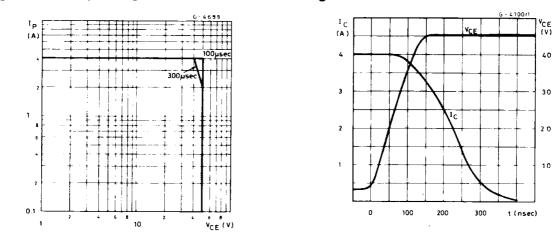


Figure 5. Safe Operating Areas.

L294

Figure 6. Turn-off Phase.



#### **CALCULATION OF THE SWITCHING TIMES**

Referring to the block diagram and to the waveforms of fig. 1, it is possible to calculate the switching times by means of the following relationships.

$$t_{r} = -\frac{L}{R_{L}} \ln \left(1 - \frac{R_{L}}{V_{1}} \cdot I_{p}\right)$$
$$t_{f} = -\frac{L}{R_{L}} \ln \frac{V2}{V2 + R_{L} \cdot I_{o}}$$

where :  $V1 = V_s - V_{sat L} - V_{sat H}$  V<sub>R sens</sub>

where :  $V2 = V_s + V_{D1} + V_{D2}$ 

 $I_K \leq I_o \leq I_p$  $I_0$  is the value of the load current at the end of  $t_{on}$ .

40

30

2 O

10

$$t_1 = t_3 = t_5 = \dots$$

$$= \begin{cases} a) - \frac{L}{R_L} \ln \frac{0.9 \ I_p \cdot R_L + V3}{I_p \ R_L + V3} & \text{where} \\ b) - R1 \ C1 \ In \ 0.9 \cong \frac{1}{10} \ R1 \ C1 \end{cases}$$

$$t_2 = t_4 = t_6 = \dots$$

$$= - \frac{L}{R_L} \ln \left(\frac{V1 - I_p \ R_L}{V1 - I_K \ R_L}\right)$$

Note that the time interval  $t_1 = t_3 = t_5 = ...$  takes the longer value between case a) and case b). The switching frequency is always :

$$f_{switching} = \frac{1}{t_1 + t_2}$$

In the case a) the main regulation loop is always closed and it forces :

In the case b), the same loop is open in the recirculation phase and  $I_K$ , which is always lower than 0.9  $I_p$ , is obtained by means of the following relationship.

$$I_{K} = I_{p} e - \frac{t_{1} R_{L}}{L} - \frac{V3}{R_{L}} (1 - e - \frac{t_{1} R_{L}}{L})$$

With the typical application circuit, in the conditions Vs = 40V, Ip = 4A, the following switching times result:  $t_r = 255 \,\mu s$  $t_f = 174 \ \mu s @ I_0 = I_p$ 

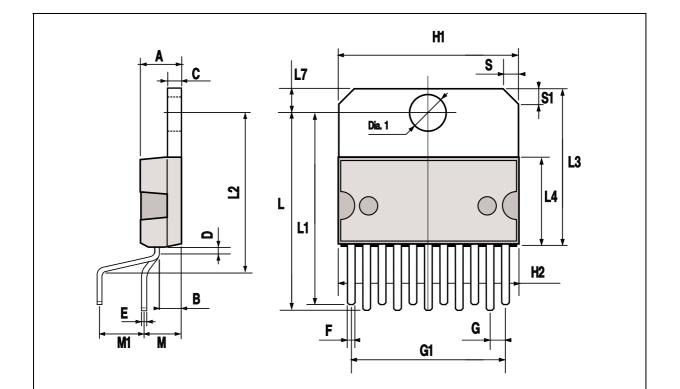
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t1 = b) 16 μs	t2 = 29 μs	f = 10.2 KHz
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DIM.		mm			inch	
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А			5			0.197
В			2.65			0.104
С			1.6			0.063
D		1			0.039	
Е	0.49		0.55	0.019		0.022
F	0.88		0.95	0.035		0.037
G	1.57	1.7	1.83	0.062	0.067	0.072
G1	16.87	17	17.13	0.664	0.669	0.674
H1	19.6			0.772		
H2			20.2			0.795
L	21.5		22.3	0.846		0.878
L1	21.4		22.2	0.843		0.874
L2	17.4		18.1	0.685		0.713
L3	17.25	17.5	17.75	0.679	0.689	0.699
L4	10.3	10.7	10.9	0.406	0.421	0.429
L7	2.65		2.9	0.104		0.114
М	4.1	4.3	4.5	0.161	0.169	0.177
M1	4.88	5.08	5.3	0.192	0.200	0.209
S	1.9		2.6	0.075		0.102
S1	1.9		2.6	0.075		0.102
Dia1	3.65		3.85	0.144		0.152







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